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Fairchild Semiconductor FDN327N

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FAIRCHILD

October 2001

# FDN327N

# N-Channel 1.8 Vgs Specified PowerTrench® MOSFET

## **General Description**

This 20V N-Channel MOSFET uses Fairchild's high voltage PowerTrench process. It has been optimized for power management applications.

# **Applications**

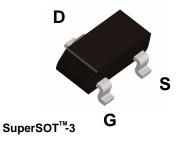
- Load switch
- Battery protection
- Power management

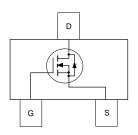
### **Features**

• 2 A, 20 V.  $R_{DS(ON)} = 70 \ m\Omega \ @ V_{GS} = 4.5 \ V$ 

$$\begin{split} R_{DS(ON)} = 80 & m\Omega \ @ \ V_{GS} = 2.5 \ V \\ R_{DS(ON)} = 120 & m\Omega \ @ \ V_{GS} = 1.8 \ V \end{split}$$

- Low gate charge (4.5 nC typical)
- · Fast switching speed
- High performance trench technology for extremely low R<sub>DS(ON)</sub>





# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	V
V <sub>GSS</sub>	Gate-Source Voltage		± 8	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	2	А
	- Pulsed	-	8	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

# **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

# Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity	
327	FDN327N	7"	8mm	3000 units	

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**Electrical Characteristics**  $T_{\Delta} = 25^{\circ}C$  unless otherwise noted Symbol **Parameter** Min Typ Max Units **Test Conditions** Off Characteristics  $V_{GS} = 0 V$ ,  $I_D=250~\mu A$ ٧  $\mathsf{BV}_{\mathsf{DSS}}$ Drain-Source Breakdown Voltage 20 Breakdown Voltage Temperature  $\Delta BV_{DSS}$  $I_D = 250 \,\mu\text{A}$ , Referenced to  $25^{\circ}\text{C}$ 12 mV/°C Coefficient  $\Delta T_J$ Zero Gate Voltage Drain Current  $V_{DS} = 16 V$ ,  $V_{GS} = 0 V$ 1 μΑ  $I_{DSS}$  $V_{GS} = 8 \text{ V},$ Gate-Body Leakage, Forward  $V_{DS} = 0 V$ 100 nΑ  $I_{GSSF}$  $I_{GSSR}$ Gate-Body Leakage, Reverse  $V_{GS} = -8 V$ ,  $V_{DS} = 0 V$ -100 nΑ On Characteristics (Note 2) Gate Threshold Voltage  $V_{DS} = V_{GS}$  $I_D = 250 \, \mu A$ 0.4 0.7 1.5 V  $V_{GS(th)}$ Gate Threshold Voltage  $I_D = 250 \,\mu\text{A}$ , Referenced to  $25^{\circ}\text{C}$  $\Delta V_{GS(th)}$ -3 mV/°C Temperature Coefficient  $\Delta T_{\perp}$ R<sub>DS(on)</sub> Static Drain-Source  $V_{GS} = 4.5 \text{ V}.$  $I_D = 2.0 A$ 40 70  $m\Omega$ On-Resistance  $V_{GS} = 2.5 V$  $I_D = 1.9 A$ 49 80  $I_D = 1.6 A$ 120  $V_{GS} = 1.8 \text{ V},$ 65  $V_{GS} = 4.5V$ ,  $I_D = 2$  A,  $T_J = 125$ °C 55 103  $I_{D(on)}$ On-State Drain Current  $V_{GS} = 4.5V$ ,  $V_{DS} = 5 V$ 8 Α Forward Transconductance s  $V_{DS} = 5V$ ,  $I_D = 2 A$ 11  $g_{\text{FS}}$ **Dynamic Characteristics**  $C_{\text{iss}}$ Input Capacitance 423 pF  $V_{DS} = 10 V$ ,  $V_{GS} = 0 V$ Coss f = 1.0 MHz 87 **Output Capacitance** pF Reverse Transfer Capacitance  $C_{\text{rss}}$ 48 рF Switching Characteristics (Note 2) Turn-On Delay Time  $V_{DD} = 10 \text{ V},$  $I_D = 1 A$ 6 12 ns t<sub>d(on)</sub>  $V_{GS} = 4.5 V$ ,  $R_{GEN} = 6 \Omega$ Turn-On Rise Time 6.5 13  $t_{r}$ ns  $t_{d(off)}$ Turn-Off Delay Time 14 29 ns Turn-Off Fall Time 2 4  $t_{\text{f}} \\$ ns  $Q_g$ **Total Gate Charge**  $V_{DS} = 10 \text{ V},$  $I_D = 2 A$ 4.5 6.3 nC  $V_{GS} = 4.5 \text{ V}$ Qgs Gate-Source Charge 0.89 nC  $Q_{gd}$ Gate-Drain Charge 0.95 nC

## **Drain-Source Diode Characteristics and Maximum Ratings**

Is	Maximum Continuous Drain-Source Diode Forward Current				0.42	Α	
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ ,	$I_S = 0.42 \text{ A}$	(Note 2)	0.6	1.2	V

#### Notes:

 R<sub>B,JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>B,C</sub> is guaranteed by design while R<sub>B,CA</sub> is determined by the user's board design.



a) 250°C/W when mounted on a 0.02 in² pad of 2 oz. copper.



b) 270°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2.0%





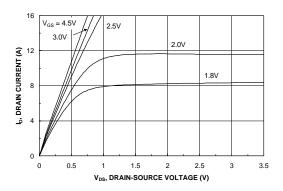


Figure 1. On-Region Characteristics.

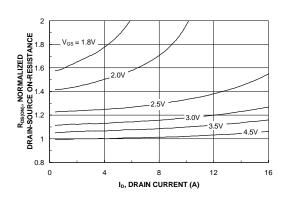


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

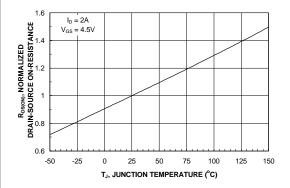


Figure 3. On-Resistance Variation with Temperature.

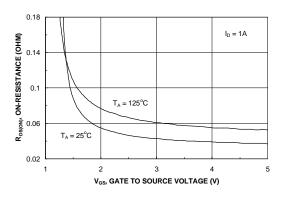


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

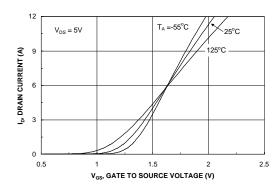


Figure 5. Transfer Characteristics.

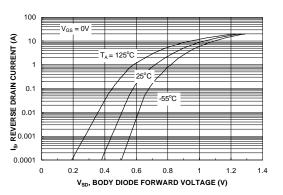
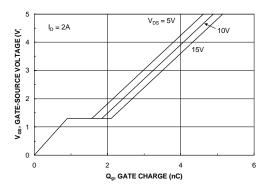


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.







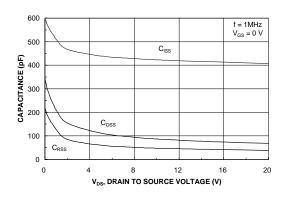
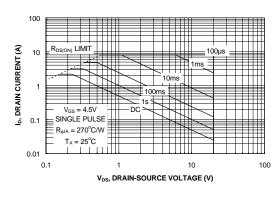


Figure 7. Gate Charge Characteristics.





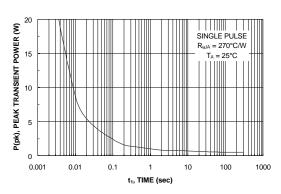


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

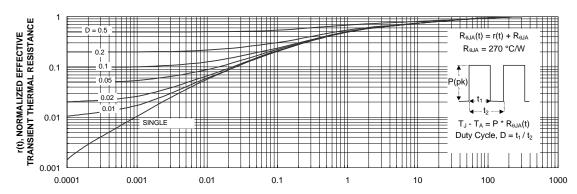


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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